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FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

ATTY. DOCKET NO. ASI-PT009.3

SERIAL NO. 09/766,815

APPLICANT Wurz, et al.

FILING DATE January 22, 2001

GROUP 287

U.S. PATENT DOCUMENTS

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EXAMINER INITIAL			C	ocu	MENT	NUME	ER		DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
HP	AA*	4	0	6	3	8	2	0	12/1977	Borgese			
HP	AB*	4	1	0	5	9	2	5	08/1978	Rossol, et al.			
M	AC*	4	1	5	8	5	0	7	06/1979	Himmel			
IM	AD*	4	2	2	7	8	1	2	10/1980	Pirlet			
M	AE*	4	2	2	7	8	1	3	10/1980	Pirlet			
BB	AF*	4	4	1	1	5	2	8	10/1983	Newcomb, et al.	-		
180	AG*	4	4	9	2	4	7	2	01/1985	Asano, et al.			
AP	AH*	4	6	4	5	9	1	7	02/1987	Penney, et al.			
18P	AI*	4	7	4	1	6	2	1	05/1988	Taft, et al.			
m	*LA	4	7	5	8	0	9	3	07/1988	Stern, et al.			
PP	AK*	4	7	5	8	7	3	0	07/1988	Brazin, et al.			
IAP	AL*	4	7	7	3	0	2	9	09/1988	Claesson, et al.	<u> </u>		

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HP	AM*	2	1	8	9	5	9	4	10/1987	GB					
AP	AN*	9	4	2	7	1	6	6	11/1994	wo					

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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APPLICANT Wurz, et al.

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL			C	ocui	MENT	NUME	SER		DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
HP	AP*	4	7	9	4	2	6	2	12/1988	Sato, et al.	_		J
INP	AQ*	4	8	1	2	6	3	9	03/1989	Byren, et al.			1
H	AR*	4	8	2	5	0	9	1	04/1989	Breyer, et al.			J
IN	AS*	4	8	8	5	4	6	1	12/1989	Matilla, et al.			√
In	AT*	4	8	.9	1	5	3	0	01/1990	Hatji			1
IN	AU*	4	9	0	6	0	9	8	03/1990	Thomas, et al.			✓
IN	AV*	4	9	2	9	8	4	3	05/1990	Chmielewski, Jr., et al.			Ţ
M	AW*	4	9	3	9	3	7	9	07/1990	Horn			√
JH	AX*	4	9	8	9	9	8	1	02/1991	Kawamura, et al.			J
188	AY*	5	0	8	5	5	1	6	02/1992	Bertrand, et al.			1
IPP	AZ*	5	1	9	3	1	2	0	03/1993	Gamache, et al.			√
AP	BA*	5	2	0	0	7	9	9	04/1993	Maruyama, et al.			j

FOREIGN PATENT DOCUMENTS

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188	BB*	9	6	1	2	9	3	1	05/1996	wo				1	
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APPLICANT Wurz, et al.

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	A6	53	4-	4	3	2	5	7-	12/78	Japan	2	G01B		-x	
	AÐ	63	1	9_	5-	5-	1	4	8/88	Japan	4	G01G		X	
	AE	<u> </u>	7	2	3	3	0	9	9/93	Japan	6	G01B	_x_		
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